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MOSFET – Power, Single N-Channel, TDFNW8 DUAL COOL[®] 150 V, 4.45 mΩ, 165 A

NVMTSC4D3N15MC

Features

- Small Footprint (8x8 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

| , , | | | | | | |
|-----------------------------------|--|-------------------------------|---------------------------|----------------|------|--|
| Symbol | Parameter | | | Value | Unit | |
| V _{DSS} | Drain-to-Source Voltage | | | 150 | V | |
| V _{GS} | Gate-to-Source Voltag | je | | ±20 | V | |
| I _D | Continuous Drain Current $R_{\theta JC}$ (Note 2) | Steady State | | | Α | |
| P _D | Power Dissipation $R_{\theta JC}$ (Note 2) | | | 292 | W | |
| I _D | Continuous Drain Current R ₀ JC (Note 2) | Steady State | | | Α | |
| P _D | Power Dissipation $R_{\theta JC}$ (Note 2) | | | 146 | W | |
| I _D | Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2) | Steady State | T _A = 25°C | 23 | Α | |
| P _D | Power Dissipation R _{θJA} (Notes 1, 2) | | | 5 | W | |
| I _D | Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2) | Steady T _A = 100°C | | 16 | Α | |
| P _D | Power Dissipation R _{θJA} (Notes 1, 2) | | | | W | |
| I _{DM} | Pulsed Drain Current | T _A = 25°C | C, t _p = 10 μs | 900 | Α | |
| T _J , T _{stg} | Operating Junction and Storage Temperature Range | | | -55 to +175 | °C | |
| I _S | Source Current (Body Diode) | | | 243 | Α | |
| E _{AS} | Single Pulse Drain-to-Source Avalanche Energy (I _L = 14.1 A _{pk} ,) | | | 3390 | mJ | |
| TL | Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s) | | | 260 | °C | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

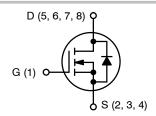
- 1. Surface-mounted on FR4 board using 1 in² pad size, 1 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted



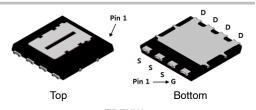
ON Semiconductor®

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| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 150 V | 4.45 mΩ @ 10 V | 165 A |

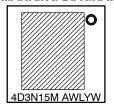


N-CHANNEL MOSFET



TDFNW8 CASE 507AS

MARKING DIAGRAM



4D3N15M = Specific Device Code

A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
W = Work Week Code

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|----------------|---------------------|-----------------------|
| NVMTSC4D3N15MC | TDFNW8 (Pb-Free) | 3000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

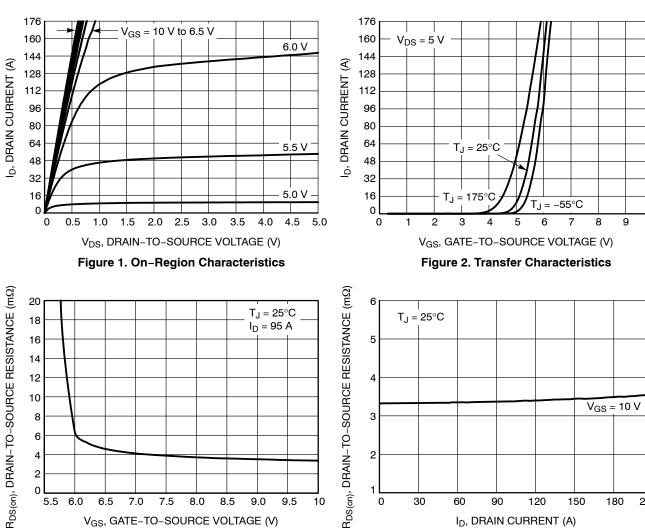
| Symbol | Parameter | Max | Unit |
|----------------|---|-----|------|
| $R_{	heta JC}$ | Junction-to-Case - Steady State (Note 2) | 0.5 | °C/W |
| $R_{	heta JC}$ | Junction-to-Case Top (Note 2) | 0.8 | |
| $R_{	hetaJA}$ | Junction-to-Ambient - Steady State (Note 2) | 28 | |

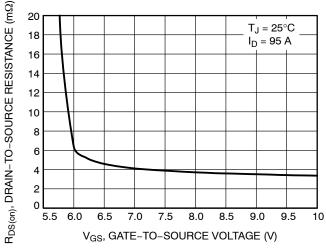
| Symbol | Parameter | Test Condition | | Min | Тур | Max | Unit |
|---------------------------------------|--|---|--------------------------------------|------|-------|------|-------|
| OFF CHARACT | ERISTICS | • | | | • | | |
| V _{(BR)DSS} | Drain – to – Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 150 | _ | - | V |
| V _{(BR)DSS} / T _J | Drain – to – Source Breakdown Voltage Temperature Coefficient | I _D = 250 μA, ref to 25°C | | - | 49.84 | - | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current $V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$ | | T _J = 25°C | - | _ | 1 | μΑ |
| | | V _{DS} = 120 V | T _J = 125°C | - | - | 10 | μΑ |
| I _{GSS} | Gate – to – Source Leakage Current | $V_{DS} = 0 \text{ V}, V_{GS}$ | = ±20 V | - | - | ±100 | nA |
| ON CHARACTE | ERISTICS (Note 3) | | | | | | |
| V _{GS(TH)} | Gate Threshold Voltage | V _{GS} = V _{DS} , I _D = | = 521 μΑ | 2.5 | 3.6 | 4.5 | V |
| V _{GS(TH)} / T _J | Negative Threshold Temperature Coefficient | I _D = 250 μA, re | I _D = 250 μA, ref to 25°C | | -9.93 | _ | mV/°C |
| R _{DS(on)} | Drain – to – Source On Resistance | V _{GS} = 10 V, I _D = 95 A | | - | 3.4 | 4.45 | mΩ |
| 9FS | Forward Transconductance | V _{DS} = 5 V, I _D = 95 A | | _ | 177 | _ | S |
| R _G | Gate-Resistance | T _A = 25°C | | _ | 1.1 | - | Ω |
| CHARGES & C | APACITANCES | | | | • | • | • |
| C _{ISS} | Input Capacitance | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 75 V | | _ | 6514 | _ | pF |
| C _{OSS} | Output Capacitance | | | _ | 1750 | - | 1 |
| C _{RSS} | Reverse Transfer Capacitance | | | _ | 12.5 | - | |
| Q _{G(TOT)} | Total Gate Charge | V _{GS} = 10 V, V _{DS} = 75 V, I _D = 95 A | | _ | 79 | _ | nC |
| Q _{G(TH)} | Threshold Gate Charge | | | _ | 21 | _ | 1 |
| Q _{GS} | Gate-to-Source Charge | | | | 36 | _ | 1 |
| Q_{GD} | Gate-to-Drain Charge | | | _ | 11 | - | |
| V _{GP} | Plateau Voltage | | | _ | 5.8 | - | |
| SWITCHING CH | HARACTERISTICS, V _{GS} = 10 V (Note 3) | • | | | | | |
| t _{d(ON)} | Turn – On Delay Time | V _{GS} = 10 V, V _D | _S =75 V, | - | 38 | - | ns |
| t _r | Rise Time | I _D = 95 A, R _G = | 6 Ω | _ | 11 | - | |
| t _{d(OFF)} | Turn – Off Delay Time | | | _ | 48 | - | |
| t _f | Fall Time | | | _ | 8 | - | |
| | CE DIODE CHARACTERISTICS | • | | | | | |
| V _{SD} | Forward Diode Voltage | $V_{GS} = 0 \text{ V},$ $I_S = 95 \text{ A}$ $T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$ | - | 0.86 | 1.2 | V | |
| - | | | _ | 0.80 | _ | 1 | |
| t _{RR} | Reverse Recovery Time | $V_{GS} = 0 \text{ V, dI}_{S}$ | dt = 100 A/μs, | - | 85 | - | ns |
| t _a | Charge Time | - I _S = 95 A | | _ | 58 | _ | 1 |
| t _b | Discharge Time | | | _ | 38 | _ | 1 |
| Q _{RR} | Reverse Recovery Charge | | | _ | 194 | _ | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS







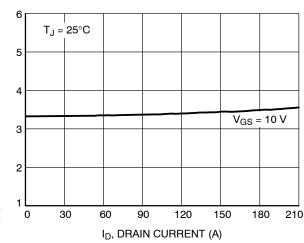


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

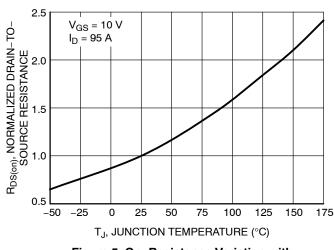


Figure 5. On-Resistance Variation with **Temperature**

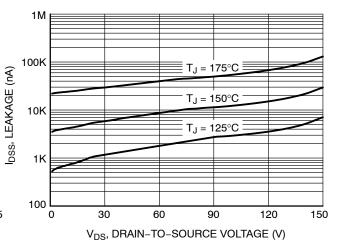
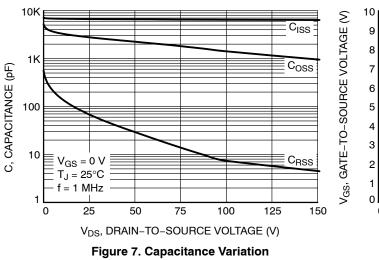


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS



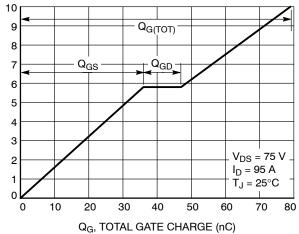


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

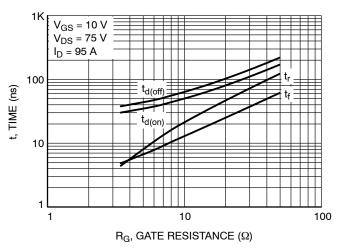


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

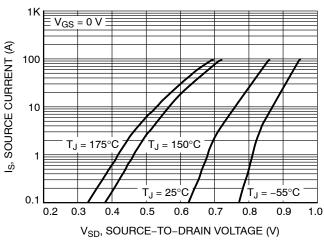


Figure 10. Diode Forward Voltage vs. Current

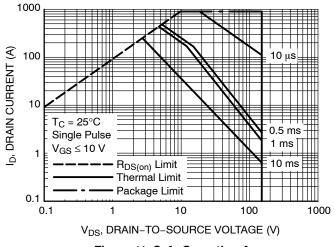


Figure 11. Safe Operating Area

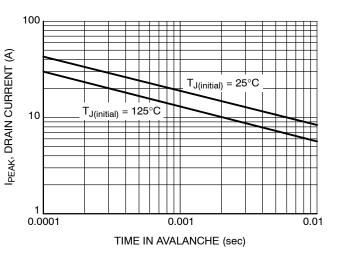


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

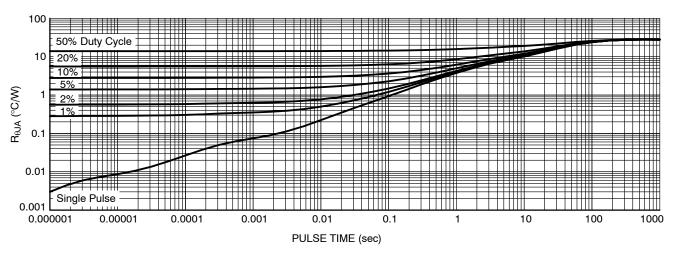
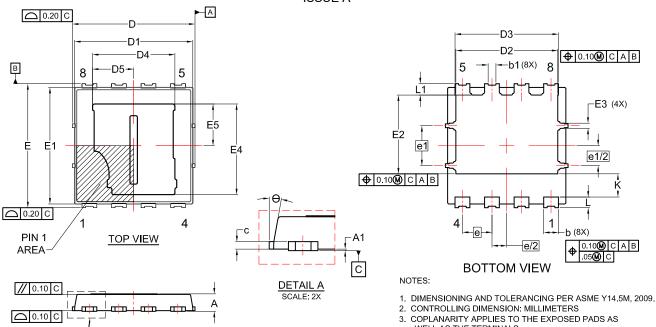
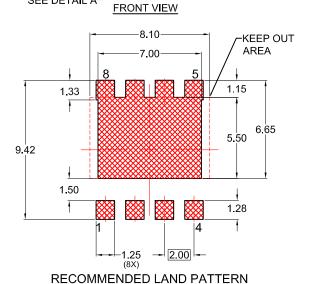


Figure 13. Thermal Characteristics

PACKAGE DIMENSIONS

TDFNW8 8.3x8.4, 2P CASE 507AS **ISSUE A**





SEE DETAIL A

- WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

 5. SEATING PLANE IS DEFINED BY THE TERMINALS.

 "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

| DIM | MILLIMETERS | | | |
|------|-------------|-------------|------|--|
| Diw | MIN. | NOM. | MAX. | |
| Α | 0.82 | 0.92 | 1.02 | |
| A1 | 0.00 | | 0.05 | |
| b | 0.90 | 1.00 | 1.10 | |
| b1 | 0.43 | 0.53 | 0.63 | |
| С | 0.23 | 0.28 | 0.33 | |
| D | 8.20 | 8.30 | 8.40 | |
| D1 | 7.90 | 8.00 | 8.10 | |
| D2 | 6.80 | 6.90 | 7.00 | |
| D3 | 6.90 | 7.00 | 7.10 | |
| D4 | 5.47 | 5.57 | 5.67 | |
| D5 | 2.69 | 2.79 | 2.89 | |
| Ε | 8.30 | 8.40 | 8.50 | |
| E1 | 7.80 | 7.90 | 8.00 | |
| E2 | 5.24 | 5.34 | 5.44 | |
| E3 | 0.25 | 0.35 | 0.45 | |
| E4 | 6.03 | 6.13 | 6.23 | |
| E5 | 2.72 | 2 2.82 2.92 | | |
| е | 2.00 BSC | | | |
| e/2 | 1.00 BSC | | | |
| e1 | 2.70 BSC | | | |
| e1/2 | 1.35 BSC | | | |
| K | 1.50 | 1.57 | 1.70 | |
| L | 0.64 | 0.74 | 0.84 | |
| L1 | 0.67 | 0.77 | 0.87 | |
| θ | 0° | | 12° | |

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